

[illegible]

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
cm	10-072579	3/17/1998	JAPAN (Full Japanese Text)	—	—	Abst. only	
cm	03-162485	7/12/1991	JAPAN (Full Japanese Text)	—	—	Abst. only	
cm	06-116552	4/26/1994	JAPAN (Full Japanese Text)	—	—	Abst. only	
cm	11-228951	8/24/1999	JAPAN (Full Japanese Text)	—	—	Abst. only	

CH	International Search Report Dated August 31, 2004

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

LIST OF ART CITED BY APPLICANT



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APPLICANT(S)

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Chun Gun PARKFILING DATE
3/4/2004GROUP
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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
um	KR 10-0204220	04/28/1997	Korea (English Abstract & Korean Full Text)	—	—		

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

um	Office Action issued by the Korean Intellectual Property Office dated March 25, 2005.

EXAMINER

C/mf

DATE CONSIDERED

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